

Search Notes

Application/Control No.

10/552,172

Examiner

Jason Benton

Applicant(s)/Patent under
Reexamination

KURITA, HIROTAKE

Art Unit

3747

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|--|-----------|----------|
| 123 | 188.11,18 8.6,193.6, 193.5,193. 1 | 6/18/2007 | JB |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|-----------|------|
| EAST: aluminum, silicon, copper, rockwell hardness ,grin size, primary crystal, eutectic. | 6/18/2007 | JB |
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